FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				ATTY DOCKET NO. 35.C15513	APPLICATION NO: 09/847,420 ,		
				APPLICANT SHUJI YAMADA ET AL.			
SEP 1 0 2001			1 0 2001	FILING DATE MAY 3, 2001	GROUP 2852		
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	HADEWARE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
ATP		6,208,071B1	03/27/01	Nishimura et al.			
						ļ <u></u>	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
ATY		10-241550	09/11/98	Japan		 	Abstract and USP 6208071 B1
ATP	_	0850892A1	07/01/98	EPO			(In English)
				•			
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
5118		W.P. Dyke, Advances in Electronics and Electron Physics, 8, 89 (1956); Field Emission.					
ATP		C.A. Spindt, Journal of Applied Physics, 47, 5248 (1976); Physical properties of thin-film field emission cathodes with molybdenum cones.					
ATP		M.I. Elinson, Radio Engineering Electron Physics, 10, 1290 (1965); The Emission of Hot Electrons and the Field Emission of Electrons from Tin Oxide.					
ATP		G. Dittmer, Thin Solid Films, 9, 317 (1972); Electrical Conduction and Electron Emission of Discontinuous Thin Films.					
ATP		M. Hartwell, IEEE Transactions Electron Devices Conference, 519 (1975); Strong Electron Emission from Patterned Tin-Indium Oxide Thin Films.					
ATP		H. Araki, Journal of the Vacuum Society of Japan, Volume 26, No. 1, p. 22 (1983); Electroforming and Electron Emission of Carbon Thin Films.					
EXAMINER	11th	200/	-	DATE CONSIDERED 4/7/03			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.